

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination	
			10/777,069	OOISHI, TSUKASA	
			Examiner	Art Unit	Page 1 of 1
			Ly D. Pham	2827	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0198080 A1	10-2003	Iwata, Yoshihisa	365/158
*	B	US-2003/0161180 A1	08-2003	Bloomquist et al.	365/173
*	C	US-2003/0156448 A1	08-2003	Hidaka, Hideto	365/171
*	D	US-2003/0117838 A1	06-2003	Hidaka, Hideto	365/171
*	E	US-2002/0057593 A1	05-2002	Hidaka, Hideto	365/171
*	F	US-6,876,575 B2	04-2005	Hidaka, Hideto	365/171
*	G	US-6,741,513 B2	05-2004	Honigschmid et al.	365/158
*	H	US-6,611,454 B2	08-2003	Hidaka, Hideto	365/171
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.